Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination
10/789,502	NAGANO ET AL.
Examiner	Art Unit
Bao Q. Vu	2838

	SEAR	CHED	
Class	Subclass	Date	Examiner
363	21.12	3/21/2005	BV
	21.15		
-	21.16		
	56.09		
	21.18		
	56.10		
	56.11		

INTERFERENCE SEARCHED				
Class	Subclass	. Date	Examiner	
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SEARCH NOTES (INCLUDING SEARCH STRATEGY)				
	DATE	EXMR		
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